Attorney's Docket No.: 09712-332001 / Z-433

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant

: Peter J. de Groot

Art Unit : 2877

Serial No.

: 10/659,060

Examiner : Marissa Detschel

Filed

: September 9, 2003

Title

: INTERFEROMETRY METHOD FOR ELLIPSOMETRY, REFLECTOMETRY, AND

SCATTEROMETRY MEASUREMENTS, INCLUDING CHARACTERIZATION OF

THIN FILM STRUCTURES

## MAIL STOP AMENDMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

## INFORMATION DISCLOSURE STATEMENT

Applicants request consideration of the references listed on the attached PTO-1449 form. Under 37 C.F.R. § 1.98 (a)(2)(ii), only copies of foreign patent documents and/or non-patent literature are enclosed. Copies of any listed U.S. patents or U.S. patent application publications can be provided upon request.

This statement is being filed after a first Office action on the merits, but before receipt of a final Office action or a Notice of Allowance. A check for \$180 in payment of the late submission fee of §1.17(p) is enclosed. Please apply any other charges or credits to Deposit Account No. 06-1050, referencing 09712-332001.

Respectfully submitted

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Sheet	1	of	1
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Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attomey's Docket No. 09712-332001	Application No. 10/659,060	
Information Disclosure Statement by Applicant		Applicant Peter J. de Groot		
JUN 1 5 2006 (Use several sheets	if necessary)	Filing Date September 9, 2003	Group Art Unit 2877	

HADEM			U.S. Pate	ent Documents			
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	5,459,564	10/17/1995	Chivers			
	AB	6,545,761	4/8/2003	Aziz et al.			
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner	Desig.	Document	Publication	Country or			Trans	slation
Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
	AL	WO 2004/023071	3/18/2004	WIPO	G01B	11/06		
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)				
Examiner Initial	Desig. ID	Document		
- mida	AQ	Document		
	AR			
-	AS			
	AT			

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if no	t in conformance and not considered. Include copy of this form with
next communication to applicant.	• •